Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/814,736	CHAMBERLAIN ET AL.	
Examiner	Art Unit	
Yaima Campos	2185	

SEARCHED				
Class	Subclass	Date	Examiner	
711	170	9/14/2006	YC	
711	171	9/14/2006	YC	
711	172	9/14/2006	YC	
711	173	9/14/2006	YC	
711	1-6	9/14/2006	YC	
711	200-221	9/14/2006	YC	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
711	170	9/14/2006	YC	
711	171	9/14/2006	YC	
711	172	9/14/2006	YC	
711	/173	9/14/2006	YC	

SEARCH NOT (INCLUDING SEARCH		<u> </u>
	DATE	EXMR
Updated PALM and EAST inventor search		
EIC Fast and Focussed Search - Bibliographic Patent Literature	·	
EIC Fast and Focusses Search - Non Patent Literature (Inspec, IEEE and Google)		
EAST, WEST Text search		
Consulted Primary Examiner Nasser G. Moazzami		